TEST REPORT

Application No.:	SEWA2310000121RG
Applicant:	Rolling Wireless S.à r.l.
Address of Applicant:	15, rue Edward Steichen, 2540 Luxembourg
Manufacturer:	Rolling Wireless S.à r.l.
Address of Manufacturer:	15, rue Edward Steichen, 2540 Luxembourg
EUT Description:	RN934A
Model No.:	RN934A
Trade Mark:	Rolling Wireless
FCC ID:	2AX2URN934A
Standards:	47 CFR Part 2 47 CFR Part 27
Date of Receipt:	2023/09/28
Date of Test:	2023/10/10 to 2023/10/30
Date of Issue:	2023/10/31
Test Result :	**PASS ***

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

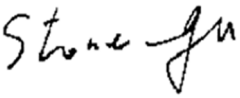
Authorized Signature:

Well Wei
Wireless Laboratory Manager

South of No. 6 Plant, No. 1, Runsheng Road, Suzhou Industrial Park, Suzhou Area, China (Jiangsu) Pilot Free Trade Zone 215000 t (86-512) 62992980 www.sgsgroup.com.cn
中国·苏州·中国（江苏）自由贸易试验区苏州片区苏州工业园区润胜路1号的6号厂房南部 邮编：215000 t (86-512) 62992980 sgs.china@sgs.com

1 Version

Revision Record				
Version	**Chapter**	**Date**	**Modifier**	**Remark**
01		2023/10/31		Original

Prepared By		 **(Levi Li) / Test Engineer**
Checked By		 **(Stone Gu) / Reviewer**

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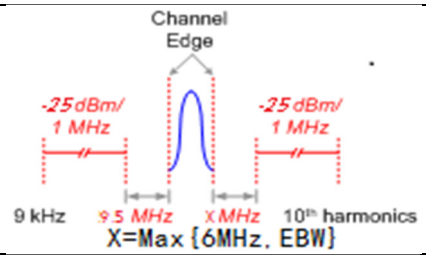
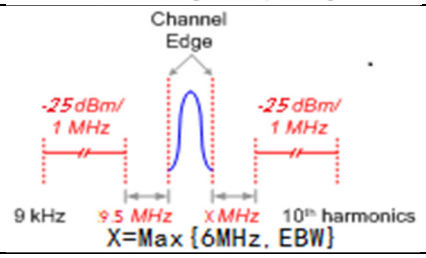
2 Test Summary

2.1 LTE Band 7/CA_7C

Test Item	FCC Rule No.	Requirements	Test Result	Verdict
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)(2)	EIRP ≤ 2W	Section 1 of Appendix B.1&B.2	Pass
Peak-Average Ratio	---	≤13 dB	Section 2 of Appendix B.1&B.2	Pass
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Section 3 of Appendix B.1&B.2	Pass
Band Edges Compliance	§2.1051, §27.53(m4)	For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz.	Section 4 of Appendix B.1&B.2	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)		Section 5 of Appendix B.1&B.2	Pass
Field Strength of Spurious Radiation	§2.1053, §27.53(m)		Section 6 of Appendix B.1&B.2	Pass
Frequency	§2.1055(a)(1)(b)	Within authorized bands of	Section 7 of	Pass

Stability	§2.1055(d)(1) §27.54	operation/frequency block.	Appendix B.1&B.2	

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3 General Information

3.1 Details of Client

Applicant:	Rolling Wireless S.à r.l.
Address of Applicant:	15, rue Edward Steichen, 2540 Luxembourg
Manufacturer:	Rolling Wireless S.à r.l.
Address of Manufacturer:	15, rue Edward Steichen, 2540 Luxembourg

3.2 Test Location

Company:	SGS-CSTC Standards Technical Services (Suzhou) Co., Ltd.
Address:	South of No. 6 Plant, No. 1, Runsheng Road, Suzhou Industrial Park, Suzhou Area, China (Jiangsu) Pilot Free Trade Zone
Post code:	215000
Test engineer:	Levi Li, Tizzy Song

3.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **A2LA (Certificate No. 6336.01)**

SGS-CSTC STANDARDS TECHNICAL SERVICES (SUZHOU) CO., LTD. is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 6336.01.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC STANDARDS TECHNICAL SERVICES (SUZHOU) CO., LTD. has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0120.

IC#: 27594.

- **FCC –Designation Number: CN1312**

SGS-CSTC STANDARDS TECHNICAL SERVICES (SUZHOU) CO., LTD. has been recognized as an accredited testing laboratory.

Designation Number: CN1312.

Test Firm Registration Number: 717327

3.4 General Description of EUT

EUT Description:	RN934A		
Model No.:	RN934A		
Trade Mark:	Rolling Wireless		
Hardware Version:	1		
Software Version:	AFPQ52XA_00.11.01.00		
IMEI:	354360450001151		
Antenna Type:	☒ External, ☐ Integrated		
Antenna Gain:	LTE Band 7: -2.5dBi		
	LTE Band CA_7C: -2.5dBi		
	Note: The antenna gain are derived from the gain information report provided by the manufacturer.		
RF Cable:	4.5dB(Below 1GHz)	4.8dB(1.0~2.4GHz)	5.2dB(2.4~3.4GHz)
Remark: As above information is provided and confirmed by the applicant. SGS is not liable to the accuracy, suitability, reliability or/and integrity of the information.			

3.5 Test Mode

Test Mode	Test Modes Description
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation
LTE/TM3	LTE system, 64QAM modulation
LTE/TM4	LTE system, 256QAM modulation
Remark: The test mode(s) are selected according to relevant radio technology specifications.	

3.6 Test Environment

Environment Parameter	101 kPa Selected Values During Tests	
Relative Humidity	44-46 % RH Ambient	
Value	Temperature(℃)	Voltage(V)
NTNV	22~23	4.0
LTLV	-30	3.4
LTHV	-30	4.2
HTLV	50	3.4
HTHV	50	4.2

Remark:

NV: Normal Voltage	LV: Low Extreme Test Voltage	HV: High Extreme Test Voltage
NT: Normal Temperature	LT: Low Extreme Test Temperature	HT: High Extreme Test Temperature

3.7 Description of Support Units

The EUT has been tested as an independent unit.

3.8 Technical Specification

Characteristics	Description				
Radio System Type	☒ LTE				
Supported Frequency Range	Band	TX	RX		
	LTE Band 7	2500 to 2570 MHz	2620 to 2690 MHz		
	LTE CA : LTE Band CA_7C				
Supported Channel Bandwidth	LTE Band 7	☒5 MHz ☒10 MHz ☒15 MHz ☒20 MHz			
	LTE Band CA_7C	☒10MHz+20MHz ☒15MHz+10MHz ☒15MHz+15MHz ☒15MHz+20MHz ☒20MHz+10MHz ☒20MHz+15MHz ☒20MHz+20MHz			
Characteristics	Description				
Designation of Emissions (Remark: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	E-UTRA:	QPSK	16QAM	64QAM	256QAM
	LTE Band 7	4M47G7D	4M48W7D	4M48W7D	4M48W7D
		8M98G7D	8M95W7D	8M94W7D	8M94W7D
		13M5G7D	13M5W7D	13M5W7D	13M5W7D
		17M9G7D	17M9W7D	17M9W7D	17M9W7D
	LTE Band CA_7C	50RB+100RB:			
		27M7G7D	27M6W7D	27M6W7D	27M7W7D
		75RB+50RB:			
		23M1G7D	23M1W7D	23M1W7D	23M1W7D
		75RB+75RB:			
		28M2G7D	28M3W7D	28M3W7D	28M3W7D
		75RB+100RB:			
		32M6G7D	32M5W7D	32M5W7D	32M5W7D
		100RB+50RB:			
		27M7G7D	27M7W7D	27M7W7D	27M7W7D
		100RB+75RB:			
		32M6G7D	32M6W7D	32M6W7D	32M5W7D
		100RB+100RB:			
		37M7G7D	37M6W7D	37M7W7D	37M6W7D

3.9 Test Frequencies

Test Mode	Bandwidth	TX / RX	RF Channel		
			Low (L)	Middle (M)	High (H)
LTE Band 7	5MHz	TX	Channel 20775	Channel 21100	Channel 21425
			2502.5 MHz	2535 MHz	2567.5 MHz
		RX	Channel 2775	Channel 3100	Channel 5825
			2622.5 MHz	2655 MHz	2687.5 MHz
	10MHz	TX	Channel 20800	Channel 21100	Channel 21400
			2505 MHz	2535 MHz	2565 MHz
		RX	Channel 2800	Channel 3100	Channel 3400
			2625 MHz	2655 MHz	2685 MHz
	15MHz	TX	Channel 20825	Channel 21100	Channel 21375
			2507.5 MHz	2535 MHz	2562.5 MHz
		RX	Channel 2825	Channel 3100	Channel 3375
			2627.5 MHz	2655 MHz	2682.5 MHz
	20MHz	TX	Channel 20850	Channel 21100	Channel 21350
			2510 MHz	2535 MHz	2560 MHz
		RX	Channel 2850	Channel 3100	Channel 3350
			2630 MHz	2655 MHz	2680 MHz

Table 4.3.1.1.7A-1: Test frequencies for CA_7C

Range	CC-Combo / N_{RB_agg} [RB]	CC1 Note1					CC2 Note1				
		BW [RB]	N_{UL}	f_{UL} [MHz]	N_{DL}	f_{DL} [MHz]	BW [RB]	N_{UL}	f_{UL} [MHz]	N_{DL}	f_{DL} [MHz]
Low	50+100	50	20805	2505.5	2805	2625.5	100	20949	2519.9	2949	2639.9
		100	20850	2510	2850	2630	50	20994	2524.4	2994	2644.4
	75+50	75	20825	2507.5	2825	2627.5	50	20945	2519.5	2945	2639.5
	75+75	75	20825	2507.5	2825	2627.5	75	20975	2522.5	2975	2642.5
	75+100	75	20828	2507.8	2828	2627.8	100	20999	2524.9	2999	2644.9
		100	20850	2510	2850	2630	75	21021	2527.1	3021	2647.1
	100+100	100	20850	2510	2850	2630	100	21048	2529.8	3048	2649.8
Mid	50+100	50	21006	2525.6	3006	2645.6	100	21150	2540	3150	2660
		100	21051	2530.1	3051	2650.1	50	21195	2544.5	3195	2664.5
	75+50	75	21051	2530.1	3051	2650.1	50	21171	2542.1	3171	2662.1
	75+75	75	21025	2527.5	3025	2647.5	75	21175	2542.5	3175	2662.5
	75+100	75	21003	2525.3	3003	2645.3	100	21174	2542.4	3174	2662.4
		100	21026	2527.6	3026	2647.6	75	21197	2544.7	3197	2664.7
	100+100	100	21001	2525.1	3001	2645.1	100	21199	2544.9	3199	2664.9
High	50+100	50	21206	2545.6	3206	2665.6	100	21350	2560	3350	2680
		100	21251	2550.1	3251	2670.1	50	21395	2564.5	3395	2684.5
	75+50	75	21277	2552.7	3277	2672.7	50	21397	2564.7	3397	2684.7
	75+75	75	21225	2547.5	3225	2667.5	75	21375	2562.5	3375	2682.5
	75+100	75	21179	2542.9	3179	2662.9	100	21350	2560	3350	2680
		100	21201	2545.1	3201	2665.1	75	21372	2562.2	3372	2682.2
	100+100	100	21152	2540.2	3152	2660.2	100	21350	2560	3350	2680

Note 1: Carriers in increasing frequency order.

4 Description of Tests

4.1 Conducted Output Power

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.2.1

The transmitter output was connected to a calibrated coaxial cable, attenuator and power meter, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The power output at the transmitter antenna port was determined by adding the value of the cable insertion loss to the power reading. The tests were performed at three frequencies (low channel, middle channel and high channel) and on the highest power levels, which can be setup on the transmitters.

Remark: Reference test setup 1

4.2 Effective (Isotropic) Radiated Power of Transmitter

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8.4

Calculate power in dBm by the following formula:

ERP (dBm) = Conducted Power (dBm) + antenna gain (dBd)

EIRP(dBm) = Conducted Power (dBm) + antenna gain (dBi)

EIRP=ERP+2.15dB

4.3 Occupied Bandwidth

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 4.2 & 4.3

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel, middle channel and high channel).The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

4.4 Band Edge at Antenna Terminals

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel).in the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to rms.

Remark: Reference test setup 1

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW ≥ 1% of the emission bandwidth
4. VBW ≥ 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

4.5 Spurious And Harmonic Emissions at Antenna Terminal

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at three frequencies (low channel and high channel).The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Remark: Reference test setup 1

Test Settings

1. Start frequency was set to 9kHz and stop frequency was set to at least 10* the fundamental frequency(Separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissinos, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

4.6 Peak-Average Ratio

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.7.2

A peak to average ratio measurement is performed at the conducted port of the EUT. For WCDMA signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level. For GSM signals, an average and a peak trace are used on a spectrum analyzer to determine the largest deviation between the average and the peak power of the EUT in a bandwidth greater than the emission bandwidth. The traces are generated with the spectrum analyzer set to zero span mode.

Remark: Reference test setup 1

Test Settings

1. The signal analyzer's CCDF measurement profile is enabled
2. Frequency = carrier center frequency
3. Measurement BW > Emission bandwidth of signal
4. The signal analyzer was set to collect one million samples to generate the CCDF curve
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power

4.7 Field Strength of Spurious Radiation

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 5.8

Below 1GHz test procedure as below:

1). The EUT was powered ON and placed on a 80cm high table in the chamber. The antenna of the transmitter was extended to its maximum length.

2). The disturbance of the transmitter was maximized on the test receiver display by raising and lowering from 1m to 4m (for the test frequency of below 30MHz, the antenna was tuned to heights 1 meter) the receive antenna and by rotating through 360° the turntable. After the fundamental emission was maximized, a field strength measurement was made.

3). Steps 1) and 2) were performed with the EUT and the receive antenna in both vertical and horizontal polarization.

4). Test the EUT in the lowest channel, the middle channel ,the Highest channel.

5). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.

6). Repeat above procedures until all frequencies measured was complete.

E (dBμV/m) = Measured amplitude level (dBμV) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB))

EIRP (dBm) = E (dBμV/m) + 20 log D − 104.8; where D is the measurement distance in meters

Above 1GHz test procedure as below:

1) Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber

2) Calculate power in dBm by the following formula:

E (dBμV/m) = Measured amplitude level (dBμV) + (Cable Loss (dB) + Antenna Factor (dB/m) – AMP(dB))

EIRP (dBm) = E (dBμV/m) + 20 log D − 104.8; where D is the measurement distance in meters

3). Test the EUT in the lowest channel, the middle channel the Highest channel

4). The radiation measurements are performed in X, Y, Z axis positioning. And found the X axis positioning which it is worse case, Only the test worst case mode is recorded in the report.

5). Repeat above procedures until all frequencies measured was complete

Remark1: Reference test setup 2

Remark2: The emission below 18G were measured at a 3m test distance, while emissions above 18GHz were measured at a 1m test distance. At a measurement distance of 1 meter the limit line was increased by 20*LOG(3/1) = 9.54 dB.

Remark: Reference test setup 2

Remark:

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & AMP. The basic equation with a sample calculation is as follows:

AF = Antenna Factor(dB/m)

Factor = Cable Factor(dB) - Preamplifier (dB)

Level = Reading Level + AF + Factor -95.26

Margin = Limit – Level

2) Scan from 9kHz to 40GHz, The disturbance between 9KHz to 30MHz and 18GHz to 40GHz was very low, and the harmonics were the highest point could be found when testing, so only the harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

3) All modes have been tested, but only the worst case data displayed in this report.

4.8 Frequency Stability / Temperature Variation

Measurement Procedure:

Frequency stability testing is performed in accordance with the guidelines of FCC KDB 971168 D01 V03r01; Section 9

. The frequency stability of the transmitter is measured by:

a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.

b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

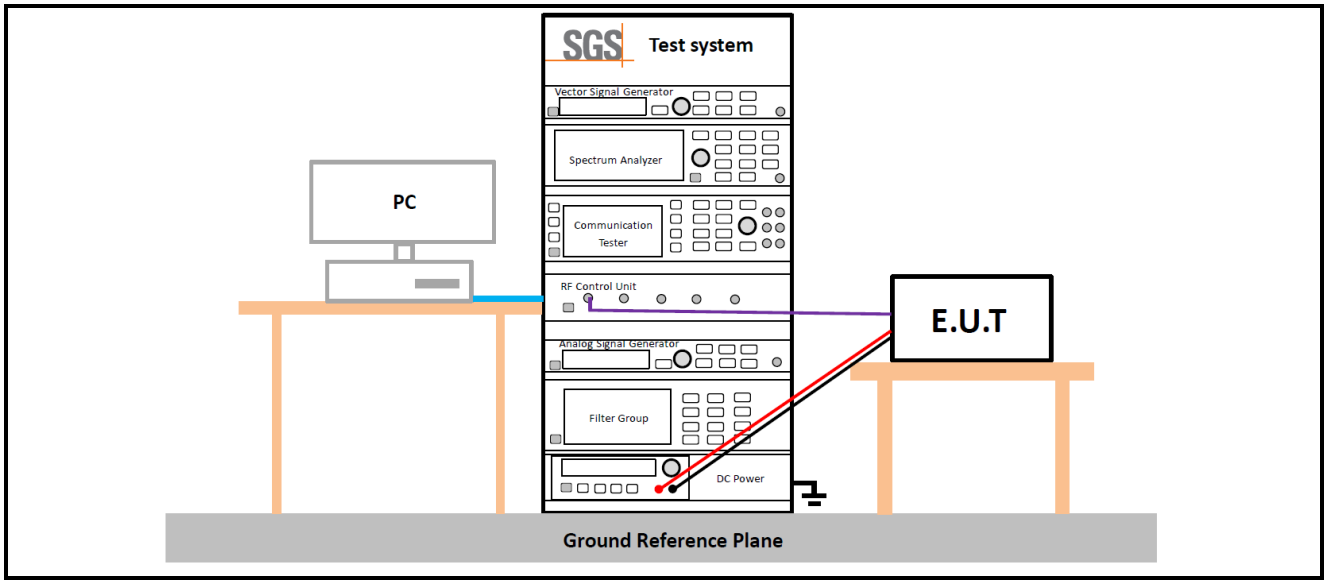
Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Remark: Reference test setup 3

4.9 Test Setups

4.9.1 Test Setup 1



4.9.2 Test Setup 2

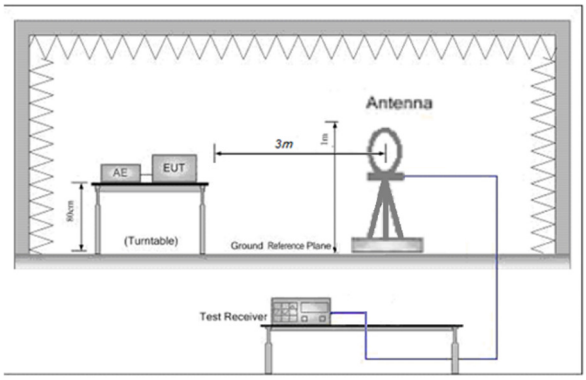


Figure 1. Below 30MHz

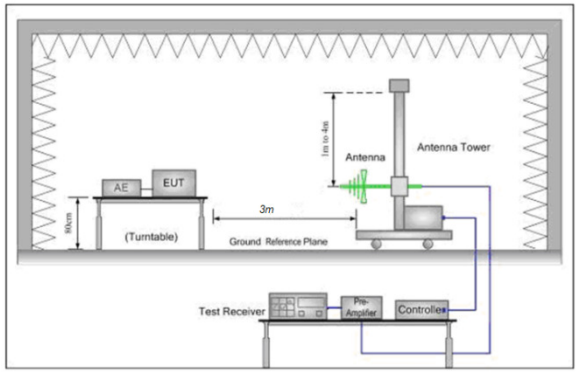


Figure 2. 30MHz to 1GHz

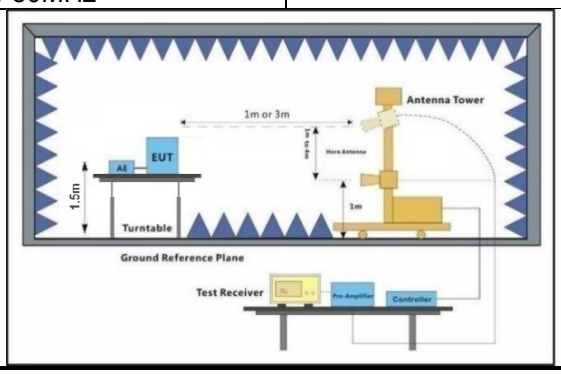
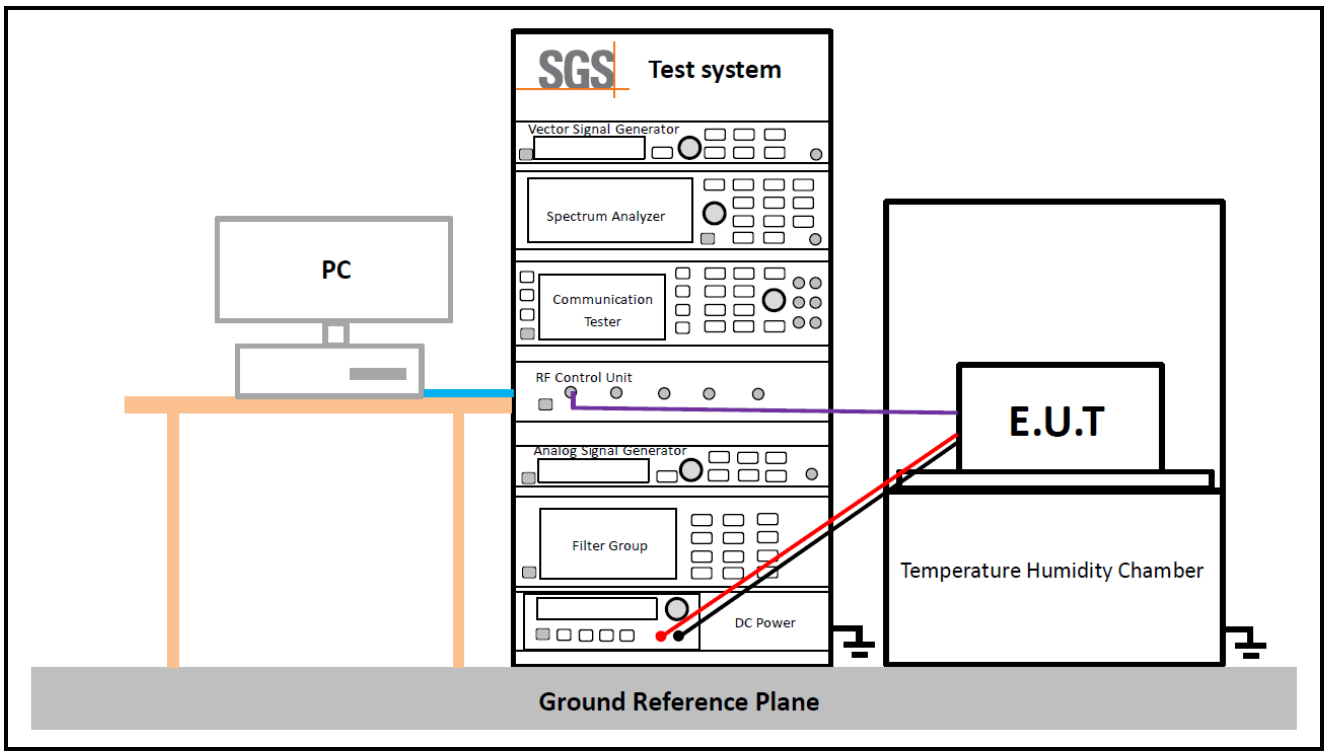


Figure 3. above 1GHz

4.9.3 Test Setup 3



4.10 Test Conditions

Transmit Output Power Data - Average Power, Total	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2; LTE/TM3; LTE/TM4

Peak-to-Average Ratio	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2; LTE/TM3; LTE/TM4

Bandwidth - Occupied Bandwidth	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2; LTE/TM3; LTE/TM4

Bandwidth - Emission Bandwidth	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1;LTE/TM2; LTE/TM3; LTE/TM4

Band Edges Compliance	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, H (L= low channel, H= high channel)
Test Mode	LTE/TM1

Spurious Emission at Antenna Terminals	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 1
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1
Field Strength of Spurious Radiation	
Test Case	**Test Conditions**
Test Environment	Ambient Climate & Rated Voltage
Test Setup	Test Setup 2
RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Test Mode	LTE/TM1 Remark: All bandwidth and modulation of LTE have been pre tested, and only the worst results are reflected in the report.
Frequency Stability	
Test Case	**Test Conditions**
Test Environment	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage (2) VL, VN and VH of Rated Voltage at Ambient Climate.
Test Setup	Test Setup 3
RF Channels (TX)	M (M= middle channel)
Test Mode	LTE/TM1 The report only show the bandwidth with the worst case.

5 Main Test Instruments

RF conducted test					
Test Equipment	**Manufacturer**	**Model No.**	**Inventory No.**	**Cal. date (yyyy/mm/dd)**	**Cal.Due date (yyyy/mm/dd)**
Shielding Room	Brilliant-emc	N/A	SUWI-04-01-06	2021/05/08	2024/05/07
Temperature and humidity meter	MingGao	TH101B	SUWI-01-01-07	2023/02/06	2024/02/05
Signal Analyzer	ROHDE&SCHWARZ	FSV3030	SUWI-01-02-02	2023/05/11	2024/05/10
Measurement Software	Tonscend	JS1120-3 Test System V 2.6.88.0336	SUWI-02-09-09	NCR	NCR
Radio Communication Analyzer	Anritsu	MT8821C	SUWI-01-26-03	2022/11/23	2023/11/22
Wideband Radio Communication Tester	ROHDE&SCHWARZ	CMW500	SUWI-01-16-05	2023/02/06	2024/02/05
DC Power Supply	HYELEC	HY3005B	SUWI-01-18-01	2023/02/06	2024/02/05
Temperature Chamber	ESPEC	SU-242	SUWI-01-13-01	2023/02/06	2024/02/05
Signal Analyzer	ROHDE&SCHWARZ	FSW43	SUWI-01-02-04	2023/05/11	2024/05/10

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RSE Test System					
Test Equipment	**Manufacturer**	**Model No.**	**Inventory No.**	**Cal. date (yyyy/mm/dd)**	**Cal.Due date (yyyy/mm/dd)**
Semi-Anechoic Chamber	Brilliant-emc	N/A	SUWI-04-02-02	2021/11/25	2024/11/24
Temperature and humidity meter	MingGao	TH101B	SUWI-01-01-13	2023/02/07	2024/02/06
Signal Analyzer	ROHDE&SCHWARZ	FSW43	SUWI-01-02-04	2023/05/11	2024/05/10
Signal Analyzer	KEYSIGHT	N9020A	SUWI-01-02-06	2022/11/23	2023/11/22
Test receiver	ROHDE&SCHWARZ	ESR7	SUWI-01-10-01	2023/02/08	2024/02/07
Receiving antenna	SCHWRZBECK MESS-ELEKTRONIK	VULB 9168	SUWI-01-11-04	2021/12/05	2023/12/04
Receiving antenna	SCHWRZBECK MESS-ELEKTRONIK	BBHA 9120D	SUWI-01-11-05	2021/12/05	2023/12/04
Receiving antenna	SCHWRZBECK MESS-ELEKTRONIK	BBHA 9170	SUWI-01-11-03	2023/05/12	2024/05/11
Active Loop Antenna	SCHWRZBECK MESS-ELEKTRONIK	FMZB 1519B	SUWI-01-21-01	2023/05/13	2024/05/12
Amplifier	Tonscend	TAP9K3G32	SUWI-01-14-06	2022/11/23	2023/11/22
Amplifier	Tonscend	TAP01018050	SUWI-01-14-04	2022/11/23	2023/11/22
Amplifier	Tonscend	TAP30M7G30	SUWI-01-14-05	2022/11/23	2023/11/22
Wideband Radio Communication Tester	Anritsu	MT8820C	SUWI-01-16-08	2023/02/06	2024/02/05
Wideband Radio Communication Tester	Anritsu	MT8821C	SUWI-01-26-03	2022/11/23	2023/11/22
Measurement Software	Tonscend	JS32-RE V4.0.0.0	SUWI-02-09-04	NCR	NCR

6 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

No.	Item	Measurement Uncertainty
1	Total RF power, conducted	±0.54dB
2	RF power density, conducted	±1.03dB
3	Spurious emissions, conducted	±0.54dB
4	Radio Frequency	±1.0 %
5	Duty Cycle	±0.37%
6	Occupied Bandwidth	±1.0 %
7	Radiated Emission	± 3.13dB (9k -30MHz)
		± 4.88dB (30M -1GHz)
		± 4.75dB (1GHz to 18GHz)
		± 4.77dB (Above 18GHz)

Remark:
The U_{lab} (lab Uncertainty) is less than $U_{cispr/ETSI}$ (CISPR/ETSI Uncertainty), so the test results
– compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
– non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

7 Appendixes

Appendix A.2	WWAN Setup Photos
Appendix B.1	LTE Band 7
Appendix B.2	LTE Band CA_7C

---End of Report---

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